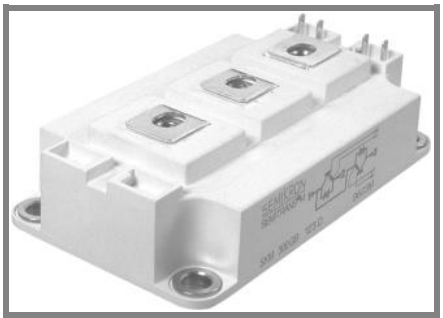
SKM 300GB123D



SEMITRANS® 3

IGBT Modules

SKM 300GB123D

SKM 300GAL123D

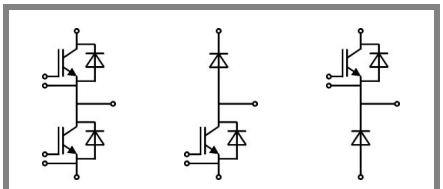
SKM 300GAR123D

Features

- MOS input (voltage controlled)
- N channel , Homogeneous Si
- Low inductance case
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to 6 x I_{cnom}
- Latch-up free
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DCB Direct Copper Bonding Technology
- Large clearance (12 mm) and creepage distance (20 mm)

Typical Applications

- AC inverter drives
- UPS

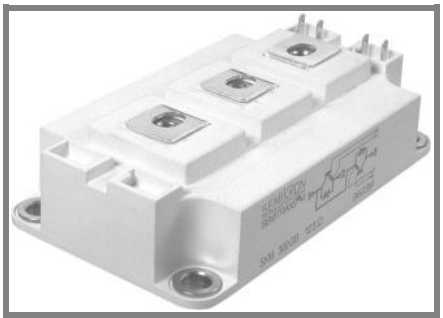


GB **GAL** **GAR**

Absolute Maximum Ratings			T_c = 25 °C, unless otherwise specified	
Symbol	**Conditions**		**Values**	**Units**
IGBT				
V_{CES}	T_j = 25 °C		1200	V
I_C	T_j = 150 °C	T_{case} = 25 °C	300	A
		T_{case} = 80 °C	220	A
I_{CRM}	I_{CRM}=2xI_{Cnom}		400	A
V_{GES}			± 20	V
t_{psc}	V_{CC} = 600 V; $V_{GE} \leq$ 20 V; V_{CES} < 1200 V	T_j = 125 °C	10	µs
Inverse Diode				
I_F	T_j = 150 °C	T_{case} = 25 °C	260	A
		T_{case} = 80 °C	180	A
I_{FRM}	I_{FRM}=2xI_{Fnom}		400	A
I_{FSM}	t_p = 10 ms; sin.	T_j = 150 °C	2200	A
Freewheeling Diode				
I_F	T_j = 150 °C	T_{case} = 25 °C	350	A
		T_{case} = 80 °C	230	A
I_{FRM}	I_{FRM}=2xI_{Fnom}		600	A
I_{FSM}	t_p = 10 ms; sin	T_j = 150 °C	2900	A
Module				
$I_{t(RMS)}$			500	A
T_{vj}			- 40...+ 150	°C
T_{stg}			- 40...+ 125	°C
V_{isol}	AC, 1 min.		2500	V

Characteristics			T_c = 25 °C, unless otherwise specified			
Symbol	**Conditions**		**min.**	**typ.**	**max.**	**Units**
IGBT						
$V_{GE(th)}$	V_{GE} = V_{CE}, I_C = 8 mA		4,5	5,5	6,5	V
I_{CES}	V_{GE} = 0 V, V_{CE} = V_{CES}	T_j = 25 °C		0,1	0,3	mA
V_{CE0}		T_j = 25 °C		1,4	1,6	V
		T_j = 125 °C		1,6	1,8	V
r_{CE}	V_{GE} = 15 V	T_j = 25°C		5,5	7	mΩ
		T_j = 125°C		7,5	9,5	mΩ
$V_{CE(sat)}$	I_{Cnom} = 200 A, V_{GE} = 15 V	T_j = 25°C$_{chiplev.}$		2,5	3	V
		T_j = 125°C$_{chiplev.}$		3,1	3,7	V
C_{ies}	V_{CE} = 25, V_{GE} = 0 V	f = 1 MHz		18	24	nF
C_{oes}				2,5	3,2	nF
C_{res}				1	1,3	nF
Q_G	-8V - +20V			2000		nC
R_{Gint}	T_j = °C			2,5		Ω
$t_{d(on)}$	R_{Gon} = 4,7 Ω	V_{CC} = 600V		250	400	ns
t_r		I_C= 200A		90	160	ns
E_{on}		T_j = 125 °C		28		mJ
$t_{d(off)}$	R_{Goff} = 4,7 Ω			550	700	ns
t_f				70	100	ns
E_{off}				26		mJ
$R_{th(j-c)}$	per IGBT				0,075	K/W

SKM 300GB123D



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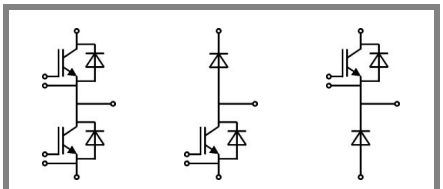


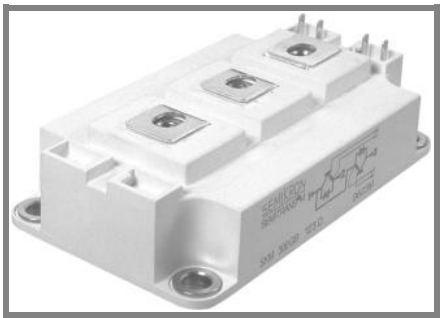
GB **GAL** **GAR**

Characteristics						
Symbol	**Conditions**		**min.**	**typ.**	**max.**	**Units**
Inverse Diode						
$V_F = V_{EC}$	I_{Fnom} = 200 A; V_{GE} = 0 V	T_j = 25 °C$_{chiplev.}$		2	2,5	V
V_{F0}		T_j = 25 °C		1,1	1,2	V
		T_j = 125 °C				V
r_F		T_j = 25 °C		4,5	6,5	mΩ
		T_j = 125 °C				mΩ
I_{RRM}	I_F = 200 A	T_j = 125 °C		105		A
Q_{rr}	di/dt = 4000 A/µs			10		µC
E_{rr}	V_{GE} = 0 V; V_{CC} = 600 V					mJ
$R_{th(j-c)D}$	per diode				0,18	K/W
Freewheeling Diode						
$V_F = V_{EC}$	I_{Fnom} = 300 A; V_{GE} = 0 V	T_j = 25 °C$_{chiplev.}$		2	2,5	V
V_{F0}		T_j = 25 °C		1,1	1,2	V
		T_j = 125 °C				V
r_F		T_j = 25 °C		3	4,3	V
		T_j = 125 °C				V
I_{RRM}	I_F = 200 A	T_j = 125 °C		140		A
Q_{rr}	di/dt = 3500 A/µs			34		µC
E_{rr}	V_{GE} = 0 V; V_{CC} = 600 V					mJ
$R_{th(j-c)FD}$	per diode				0,15	K/W
Module						
L_{CE}				15	20	nH
$R_{CC'+EE'}$	res., terminal-chip	T_{case}= 25 °C		0,35		mΩ
		T_{case}= 125 °C		0,5		mΩ
$R_{th(c-s)}$	per module				0,038	K/W
M_s	to heat sink M6		3		5	Nm
M_t	to terminals M6		2,5		5	Nm
w					325	g

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.

SKM 300GB123D



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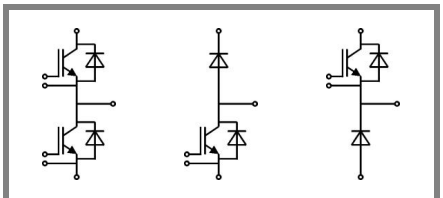
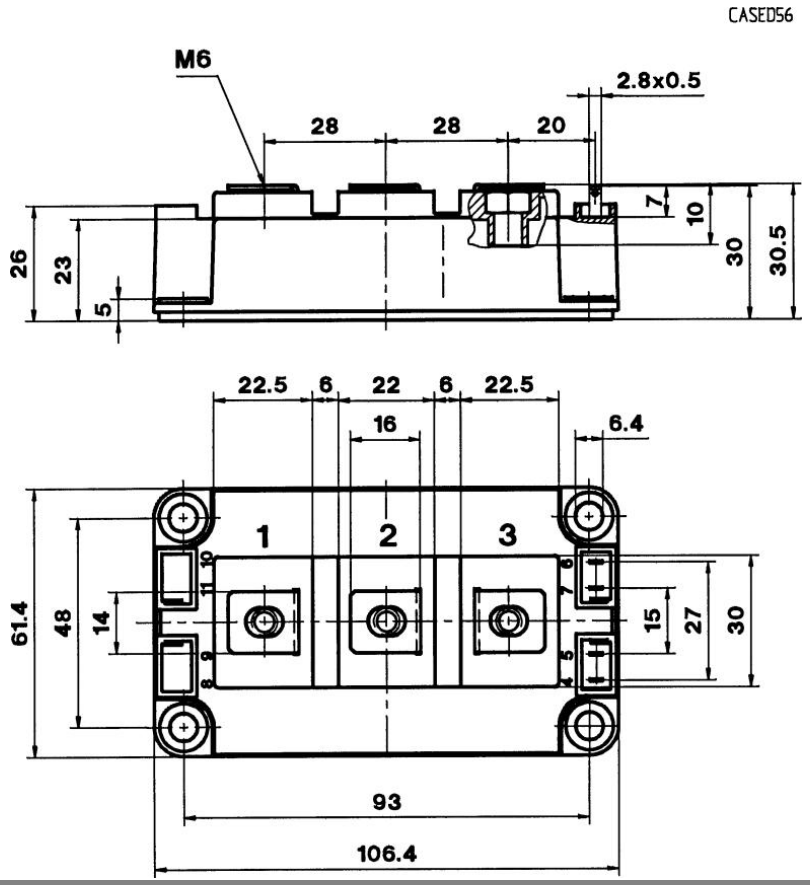


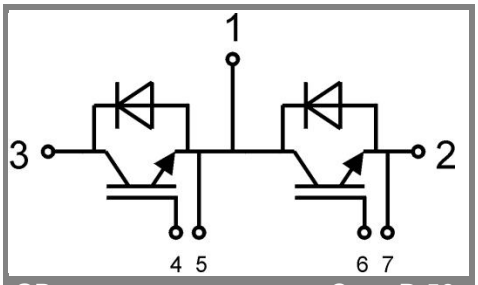
GB **GAL** **GAR**

Z_{th} Symbol	Conditions	Values	Units
$Z_{th(j-c)I}$			
R_i	i = 1	53	mk/W
R_i	i = 2	18,5	mk/W
R_i	i = 3	3,1	mk/W
R_i	i = 4	0,4	mk/W
tau_i	i = 1	0,04	s
tau_i	i = 2	0,0189	s
tau_i	i = 3	0,0017	s
tau_i	i = 4	0,003	s
$Z_{th(j-c)D}$			
R_i	i = 1	0,1151	mk/W
R_i	i = 2	0,0525	mk/W
R_i	i = 3	0,0111	mk/W
R_i	i = 4	0,0022	mk/W
tau_i	i = 1	0,0366	s
tau_i	i = 2	0,0113	s
tau_i	i = 3	0,003	s
tau_i	i = 4	0,0002	s

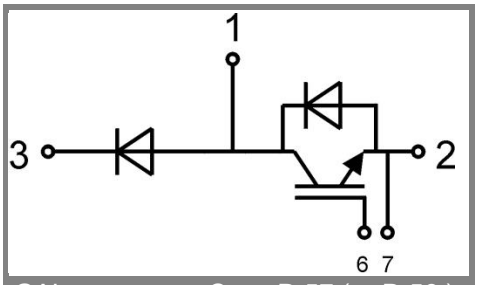
UL Recognized File 63 532



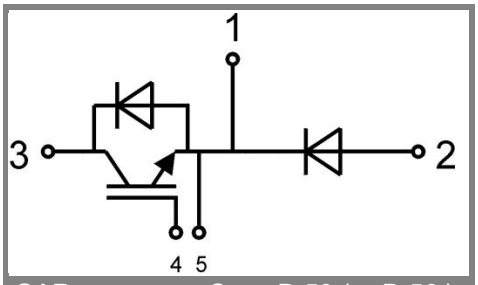
Case D 56



GB Case D 56



GAL Case D 57 (➞ D 56)



GAR Case D 58 (➞ D 56)

